U.S. Patent Documents

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Examiner Initial	Cite No.	Document No.	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear		
	Α	2003/0215220	11/2003	Ohmura et al.			
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Foreign Patent Documents

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Initial	No.	Document No.	Date	or Applicant of Cited Document	Lines, where Relevant Passages or Relevant Figures Appear	YES	NO
	L	EP 0 889 638	1/1999	Matsushima			
	М	JP 11-127415	5/1999	Omura et al.			x
	N	JP 11-243484	9/1999	Matsushima			х
	0	JP 2002-006390	1/2002	Okamori et al.			х
	Р	JP 2002-185771	6/2002	Yoshida et al.			х
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Non Patent Literature Documents

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	R	Abstract of Japanese Patent Publication No. 11-127415
		Pub. Date: 11 May 1999, Patent Abstracts of Japan
	S	Abstract of Japanese Patent Publication No. 11-243484
		Pub. Date: 07 September 1999, Patent Abstracts of Japan
	T	Abstract of Japanese Patent Publication No. 2002-006390
		Pub. Date: 09 January 2002, Patent Abstracts of Japan
	U	Abstract of Japanese Patent Publication No. 2002-185771
		Pub. Date: 28 June 2002, Patent Abstracts of Japan
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